

# **Notice of References Cited**

Application/Control No.

10/049,645

Applicant(s)/Patent Under  
Reexamination  
MIYACHI ET AL.

Examiner

Rebecca L Anderson

Art Unit

1626

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,223,522	06-1993	Clark et al.	514/369
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 0 846 693	06-1998	Europe	Maeda et al.	
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	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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